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November 2013

FDP12N60NZ / FDPF12N60NZ N-Channel UniFETTM II MOSFET 600 V, 12 A, 650 m Ω

Features

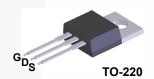
- $R_{DS(on)}$ = 530 $m\Omega$ (Typ.) @ V_{GS} = 10 V, I_D = 6 A
- Low Gate Charge (Typ. 26 nC)
- Low C_{rss} (Typ. 12 pF)
- · 100% Avalanche Tested
- · Improved dv/dt Capability
- · ESD Improved Capability
- RoHS Compliant

Applications

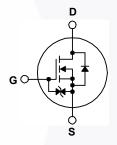
- LCD/ LED/ PDP TV
- Lighting
- · Uninterruptible Power Supply

Description

UniFETTM II MOSFET is Fairchild Semiconductor's high voltage MOSFET family based on advanced planar stripe and DMOS technology. This advanced MOSFET family has the smallest on-state resistance among the planar MOSFET, and also provides superior switching performance and higher avalanche energy strength. In addition, internal gate-source ESD diode allows UniFET II MOSFET to withstand over 2kV HBM surge stress. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.







MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

| Symbol | | Parameter | FD | P12N60NZ | FDPF12N60NZ | Unit | |
|-----------------------------------|---|---|-------|----------|-------------|------|--|
| V_{DSS} | Drain to Source Voltage | Drain to Source Voltage | | | 600 | | |
| V_{GSS} | Gate to Source Voltage | | | ±30 | | | |
| | Drain Current | - Continuous (T _C = 25°C) | | 12 | 12* | ^ | |
| ID | Diam Current | - Continuous (T _C = 100°C) | | 7.2 | 7.2* | Α | |
| I _{DM} | Drain Current - Pulsed (Note 1) | | te 1) | 48 | 48* | Α | |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | | te 2) | 565 | | mJ | |
| I _{AR} | Avalanche Current (Note 1 | | te 1) | 12 | | Α | |
| E _{AR} | Repetitive Avalanche Energy (Note 1) | | te 1) | 24 | | mJ | |
| dv/dt | MOSFET dv/dt Ruggedness | | | 20 | | V/ns | |
| uv/ut | Peak Diode Recovery dv/dt | (No | te 3) | 3) 10 | | V/ns | |
| Б | $(T_C = 25^{\circ}C)$ | | | 240 | 39 | W | |
| P_{D} | Power Dissipation - Derate Above 25°C | | | 2.0 | 0.3 | W/°C | |
| T _J , T _{STG} | Operating and Storage Temperature Range -55 to +150 | | | +150 | °C | | |
| T _L | Maximum Lead Temperature for | or Soldering, 1/8" from Case for 5 Seco | nds | 30 | 00 | °C | |

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

| Symbol | Parameter FDI | | FDPF12N60NZ | Unit |
|-----------------|---|------|-------------|--------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max. | 0.52 | 3.2 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient, Max. | 62.5 | 62.5 | - 0/00 |

Package Marking and Ordering Information

| Part Number | Top Mark | Package | Packing Method | Reel Size | Tape Width | Quantity |
|-------------|-------------|---------|----------------|-----------|------------|----------|
| FDP12N60NZ | FDP12N60NZ | TO-220 | Tube | N/A | N/A | 50 units |
| FDPF12N60NZ | FDPF12N60NZ | TO-220F | Tube | N/A | N/A | 50 units |

Electrical Characteristics T_C = 25°C unless otherwise noted.

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|---|--|---|------|------|------|------|
| Off Charac | cteristics | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V, T_J = 25^{\circ} C$ | 600 | - | - | V |
| ΔBV _{DSS} / ΔT _J | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | - | 0.6 | - | V/°C |
| 1 | Zero Gate Voltage Drain Current | V _{DS} = 600 V, V _{GS} = 0 V | - | - | 1 | |
| IDSS | Zero Gate voltage Drain Current | $V_{DS} = 480 \text{ V}, T_{C} = 125^{\circ}\text{C}$ | - | - | 10 | μΑ |
| I _{GSS} | Gate to Body Leakage Current | V _{GS} = ±30 V, V _{DS} = 0 V | - | - | ±10 | μΑ |

On Characteristics

| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS} = V_{DS}, I_{D} = 250 \mu A$ | 3 | - | 5 | V |
|---------------------|--------------------------------------|--|---|------|------|---|
| R _{DS(on)} | Static Drain to Source On Resistance | $V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$ | - | 0.53 | 0.65 | Ω |
| 9 _{FS} | Forward Transconductance | V _{DS} = 20 V, I _D = 6 A | - | 13.5 | - | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V 05.V.V 0.V | | - | 1260 | 1676 | pF |
|---------------------|-------------------------------|---|----------|-----|------|------|----|
| C _{oss} | Output Capacitance | V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz | | - | 150 | 200 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1 1/11/12 | - | - \ | 12 | 18 | pF |
| Q _{g(tot)} | Total Gate Charge at 10V | V _{DS} = 480 V, I _D = 12 A, | | - \ | 26 | 34 | nC |
| Q_{gs} | Gate to Source Gate Charge | V _{GS} = 10 V | - | - | 6 | - | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | (| (Note 4) | - | 10 | - | nC |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | | - | 25 | 60 | ns |
|---------------------|---------------------|---|---|----|-----|----|
| t _r | | $V_{DD} = 300 \text{ V}, I_D = 12 \text{ A},$ | - | 50 | 110 | ns |
| t _{d(off)} | Turn-Off Delay Time | V_{GS} = 10 V, R_G = 25 Ω | - | 80 | 170 | ns |
| t _f | Turn-Off Fall Time | (Note 4) | - | 60 | 130 | ns |

Drain-Source Diode Characteristics

| Is | Maximum Continuous Drain to Source Dioc | Maximum Continuous Drain to Source Diode Forward Current | | - | 12 | Α |
|-----------------|---|--|---|-----|-----|----|
| I _{SM} | Maximum Pulsed Drain to Source Diode Fo | orward Current | - | - | 48 | Α |
| V_{SD} | Drain to Source Diode Forward Voltage | V _{GS} = 0 V, I _{SD} = 12 A | - | - | 1.4 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _{SD} = 12 A, | - | 350 | / - | ns |
| Q _{rr} | Reverse Recovery Charge | dI _F /dt = 100 A/μs | - | 2.2 | - | μС |

- 1: Repetitive rating: pulse-width limited by maximum junction temperature.
- 2: L = 7.85 mH, I_{AS} = 12 A, V_{DD} = 50 V, R_{G} = 25 Ω , starting T_{J} = 25°C. 3: I_{SD} \leq 12 A, di/dt \leq 200 A/ μ s, V_{DD} \leq BV $_{DSS}$, starting T_{J} = 25°C.
- 4: Essentially independent of operating temperature typical characteristics.

Typical Performance Characteristics

Figure 1. On-Region Characteristics

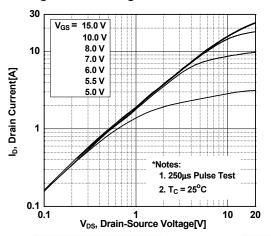


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

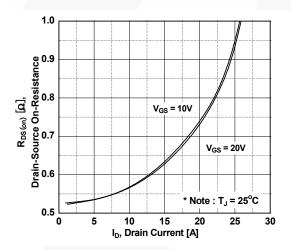


Figure 5. Capacitance Characteristics

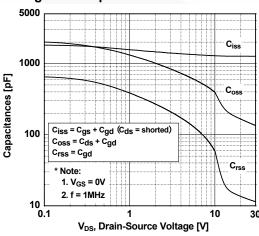


Figure 2. Transfer Characteristics

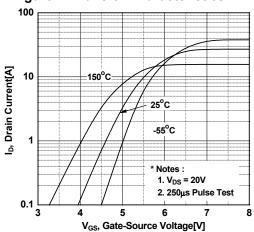


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

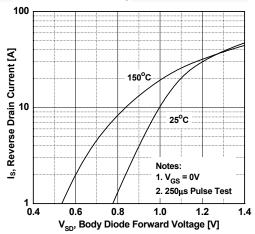
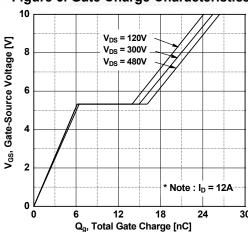


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

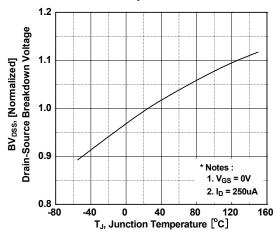


Figure 9. Maximum Safe Operating Area - FDPF12N60NZ

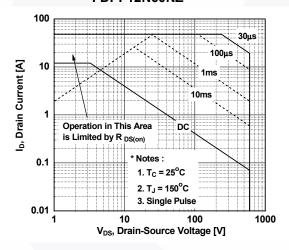


Figure 8. On-Resistance Variation vs Temperature

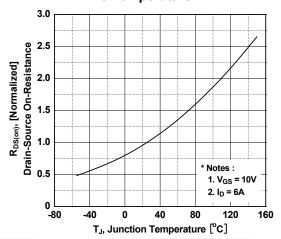


Figure 10. Maximum Safe Operating Area - FDP12N60NZ

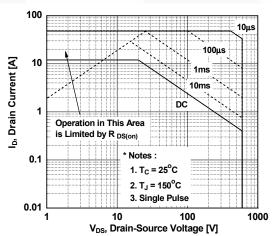
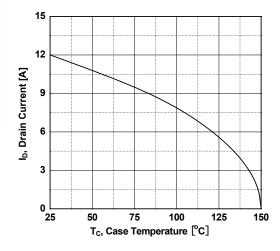


Figure 11. Maximum Drain Current vs. Case Temperature



Typical Performance Characteristics (Continued)

Figure 12. Transient Thermal Response Curve - FDPF12N60NZ

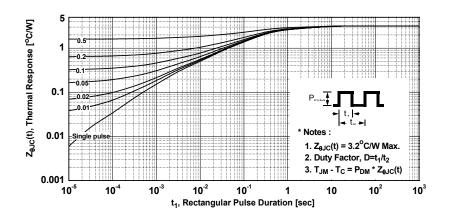
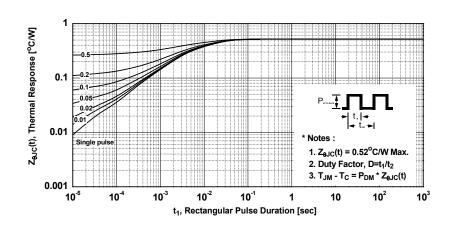


Figure 13. Transient Thermal Response Curve - FDP12N60NZ



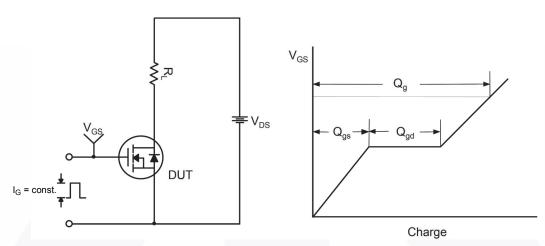


Figure 14. Gate Charge Test Circuit & Waveform

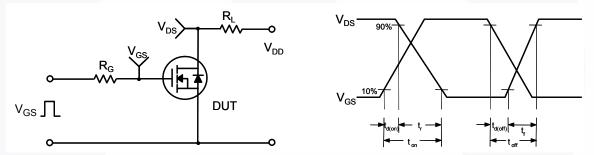


Figure 15. Resistive Switching Test Circuit & Waveforms

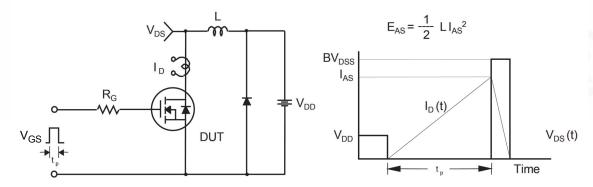


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

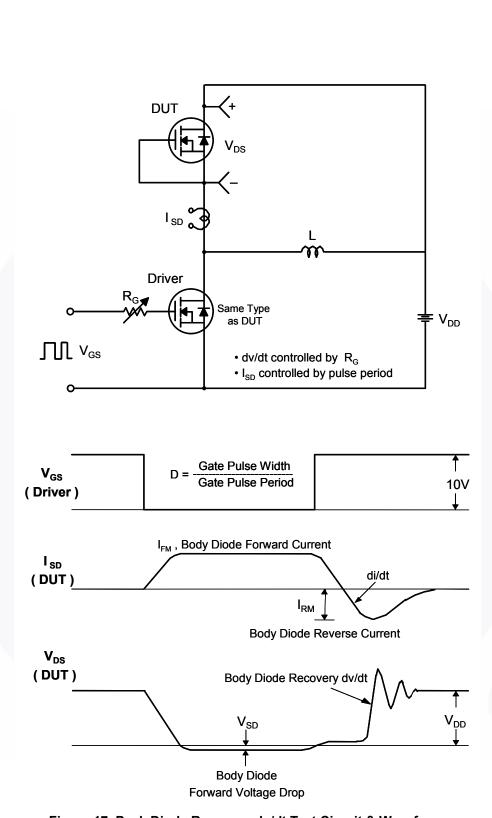


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

Mechanical Dimensions

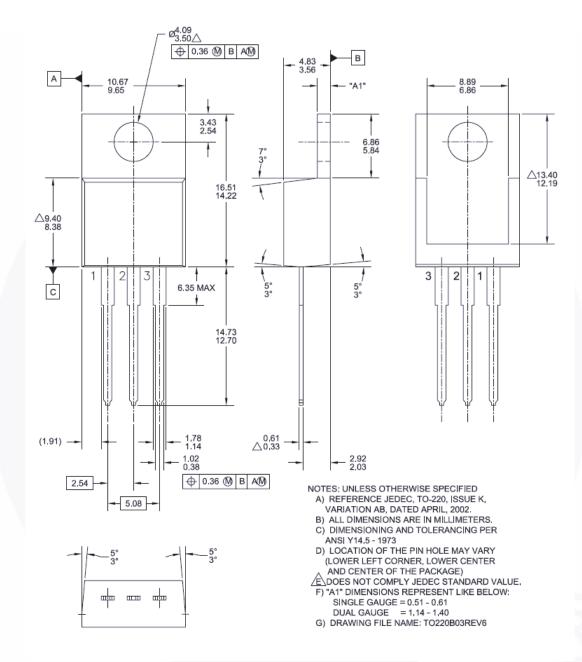


Figure 18. TO-220, Molded, 3-Lead, Jedec Variation AB

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Mechanical Dimensions

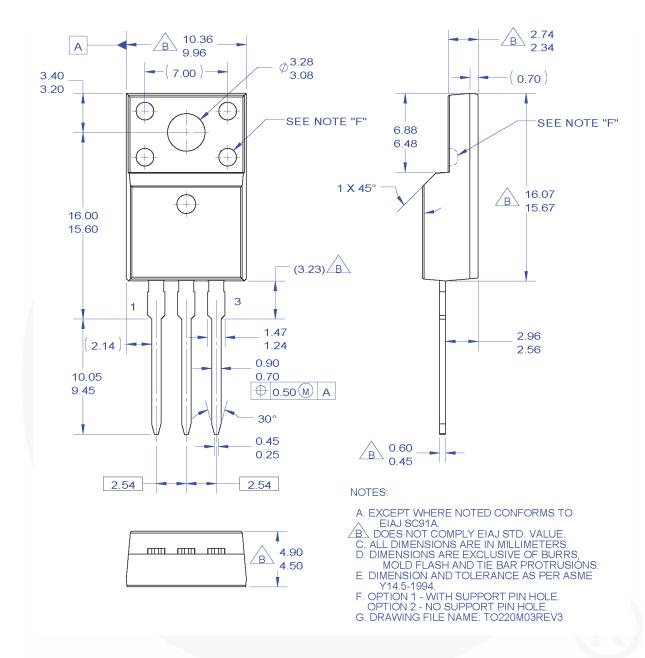


Figure 19. TO220, Molded, 3-Lead, Full Pack, EIAJ SC91, Straight Lead

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